

FORM PTO-1449 TO BE FILED WITH INFORMATION DISCLOSURE STATEMENT

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INFORMATION	Prabir K. Dutta et Applicant	al.
DISCLOSURE STATEMENT BY APPLICANTS	July 12, 2001 Filing Date	<u>2632</u> Group Art Unit
		VAN TRIEU Examiner's name

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Examiner's Initial	Document Number	Date	Name	Class/Sub-
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	NONE			

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